



BUK9K25-40RA

Dual N-channel 40 V, 29 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology

2 December 2020

Product data sheet

1. General description

Dual, logic level N-channel MOSFET in an LPAK56D package, using Application Specific (ASFET) repetitive avalanche silicon technology. This product has been designed and qualified to AEC-Q101 for use in repetitive avalanche applications.

2. Features and benefits

- Fully automotive qualified to AEC-Q101 at 175 °C
- Repetitive Avalanche rated to 30 °C T_j rise:
 - Tested to 1 Bn avalanche events
- LPAK copper clip package technology:
 - High robustness and reliability
 - Gull wing leads for high manufacturability and AOI

3. Applications

- 12 V, 24 V and 48 V automotive systems
- Repetitive avalanche topologies
- Engine control
- Transmission control
- Actuator and auxiliary loads

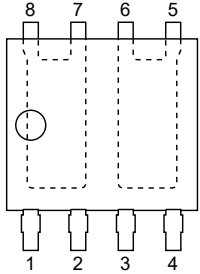
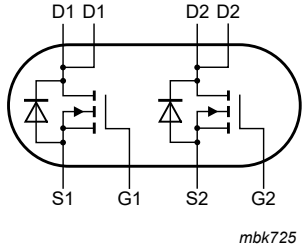
4. Quick reference data

Table 1. Quick reference data

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--|----------------------------------|--|-----|-----|------|------|
| V_{DS} | drain-source voltage | $25\text{ °C} \leq T_j \leq 175\text{ °C}$ | - | - | 40 | V |
| I_D | drain current | $V_{GS} = 5\text{ V}$; $T_{mb} = 25\text{ °C}$; Fig. 2 | - | - | 18.2 | A |
| P_{tot} | total power dissipation | $T_{mb} = 25\text{ °C}$; Fig. 1 | - | - | 32 | W |
| Static characteristics FET1 and FET2 | | | | | | |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 5\text{ V}$; $I_D = 5\text{ A}$; $T_j = 25\text{ °C}$; Fig. 14 | - | 24 | 29 | mΩ |
| Dynamic characteristics FET1 and FET2 | | | | | | |
| Q_{GD} | gate-drain charge | $I_D = 5\text{ A}$; $V_{DS} = 32\text{ V}$; $V_{GS} = 5\text{ V}$; $T_j = 25\text{ °C}$; Fig. 16 ; Fig. 17 | - | 2.4 | - | nC |

5. Pinning information

Table 2. Pinning information

| Pin | Symbol | Description | Simplified outline | Graphic symbol |
|-----|--------|-------------|---|---|
| 1 | S1 | source1 |  <p>LFAK56D; Dual LFAK (SOT1205)</p> |  <p>mbk725</p> |
| 2 | G1 | gate1 | | |
| 3 | S2 | source2 | | |
| 4 | G2 | gate2 | | |
| 5 | D2 | drain2 | | |
| 6 | D2 | drain2 | | |
| 7 | D1 | drain1 | | |
| 8 | D1 | drain1 | | |

6. Ordering information

Table 3. Ordering information

| Type number | Package | | Version |
|--------------|--------------------|--|---------|
| | Name | Description | |
| BUK9K25-40RA | LFAK56D; Dual LFAK | plastic, single ended surface mounted package (LFAK56D); 8 leads | SOT1205 |

7. Marking

Table 4. Marking codes

| Type number | Marking code |
|--------------|--------------|
| BUK9K25-40RA | 92540RA |

8. Limiting values

Table 5. Limiting values

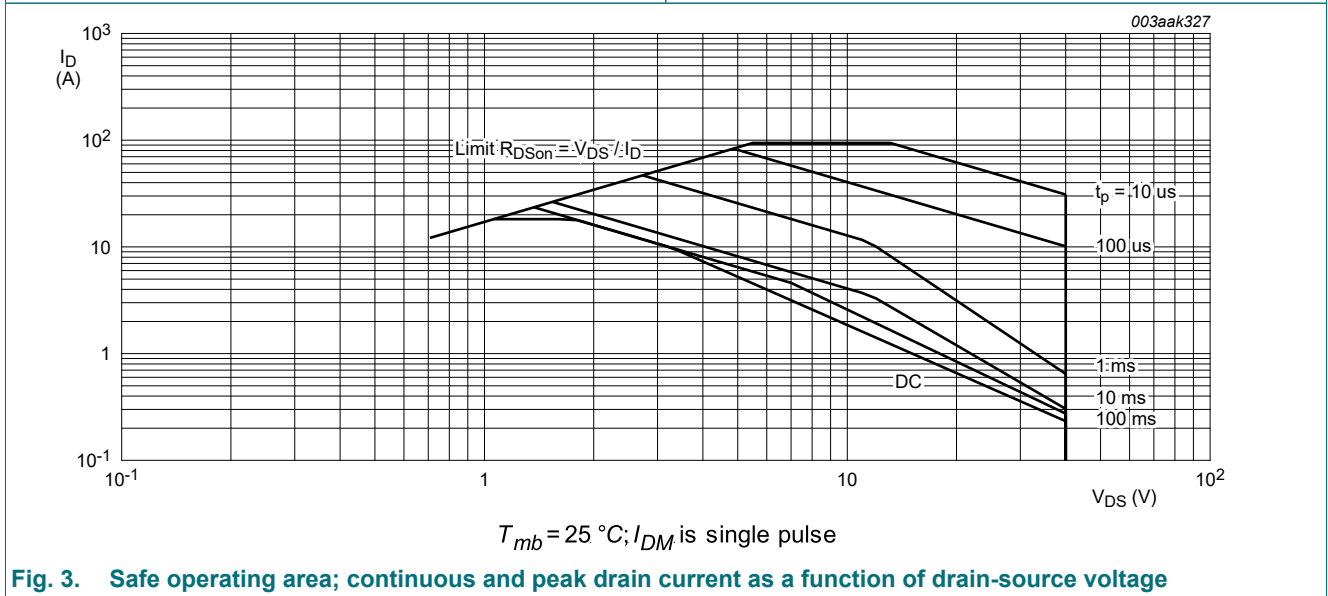
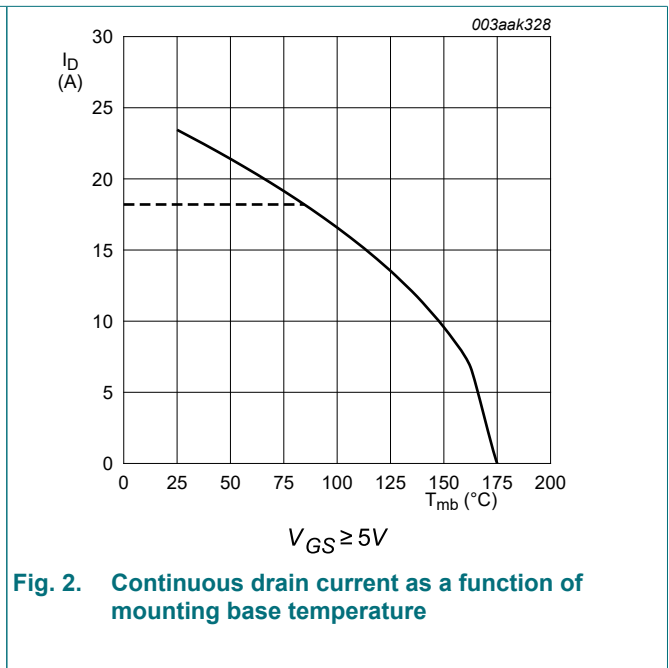
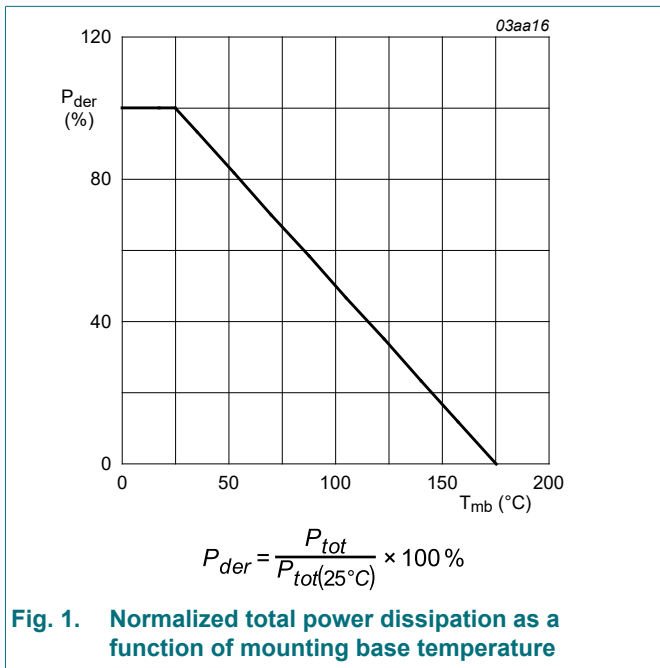
In accordance with the Absolute Maximum Rating System (IEC 60134).

| Symbol | Parameter | Conditions | Min | Max | Unit | |
|---|-------------------------|---|---------|------|------|---|
| V_{DS} | drain-source voltage | $25\text{ °C} \leq T_j \leq 175\text{ °C}$ | - | 40 | V | |
| V_{DGR} | drain-gate voltage | $R_{GS} = 20\text{ k}\Omega$ | - | 40 | V | |
| V_{GS} | gate-source voltage | Pulsed; $T_j \leq 175\text{ °C}$ | [1] [2] | -15 | 15 | V |
| | | DC; $T_j \leq 175\text{ °C}$ | | -10 | 10 | V |
| P_{tot} | total power dissipation | $T_{mb} = 25\text{ °C}$; Fig. 1 | - | 32 | W | |
| I_D | drain current | $V_{GS} = 5\text{ V}$; $T_{mb} = 25\text{ °C}$; Fig. 2 | - | 18.2 | A | |
| | | $V_{GS} = 5\text{ V}$; $T_{mb} = 100\text{ °C}$; Fig. 2 | - | 16.6 | A | |
| I_{DM} | peak drain current | pulsed; $t_p \leq 10\text{ }\mu\text{s}$; $T_{mb} = 25\text{ °C}$; Fig. 3 | - | 94 | A | |
| T_{stg} | storage temperature | | -55 | 175 | °C | |
| T_j | junction temperature | | -55 | 175 | °C | |
| Source-drain diode FET1 and FET2 | | | | | | |
| I_S | source current | $T_{mb} = 25\text{ °C}$ | - | 18.2 | A | |
| I_{SM} | peak source current | pulsed; $t_p \leq 10\text{ }\mu\text{s}$; $T_{mb} = 25\text{ °C}$ | - | 94 | A | |

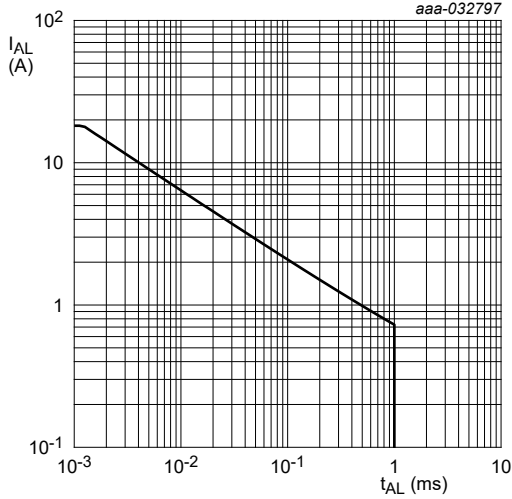
Dual N-channel 40 V, 29 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology

| Symbol | Parameter | Conditions | Min | Max | Unit | |
|---|--|--|-------------|-----|------|----|
| Avalanche ruggedness | | | | | | |
| $E_{DS(AL)R}$ | repetitive drain-source avalanche energy | $I_D = 0.73 \text{ A}$; $V_{sup} \leq 40 \text{ V}$; $R_{GS} = 10 \Omega$; $V_{GS} = 10 \text{ V}$; $T_{j(rise)} \leq 30 \text{ }^\circ\text{C}$; unclamped; Fig. 4; Fig. 5; Fig. 6 | [3] [4] [5] | - | 19 | mJ |
| Avalanche ruggedness FET1 and FET2 | | | | | | |
| $E_{DS(AL)S}$ | non-repetitive drain-source avalanche energy | $I_D = 18.2 \text{ A}$; $V_{sup} \leq 40 \text{ V}$; $V_{GS} = 10 \text{ V}$; $T_{j(init)} = 25 \text{ }^\circ\text{C}$; Fig. 7 | [6] [7] | - | 15 | mJ |

- [1] Accumulated Pulse duration up to 50 hours delivers zero defect ppm.
- [2] Significantly longer life times are achieved by lowering T_j and/or V_{GS} .
- [3] Repetitive avalanche rating is limited by maximum junction temperature of 175 °C and junction rise of 30 °C
- [4] Refer to Fig. 5 for the limiting number of avalanche events
- [5] Refer to Fig. 6 R_{Dson} at $V_{GS}=5\text{V}$ will increase as a function of repetitive avalanche cycles
- [6] Refer to application note AN10273 for further information
- [7] Single-pulse avalanche rating limited by maximum junction temperature of 175 °C



Dual N-channel 40 V, 29 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology



T_j is limited to 175 °C and $T_{j(\text{rise})}$ is limited to 30 °C

Fig. 4. Repetitive avalanche rating; avalanche current as a function of avalanche time

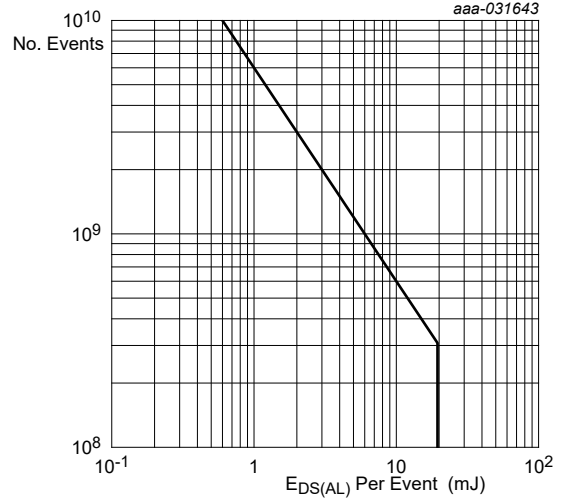


Fig. 5. Repetitive avalanche rating; maximum number of avalanche events as a function of avalanche energy

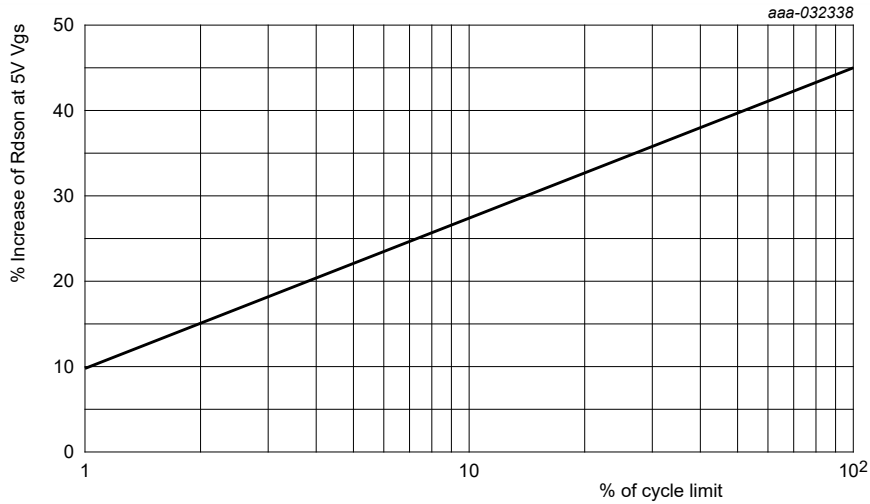
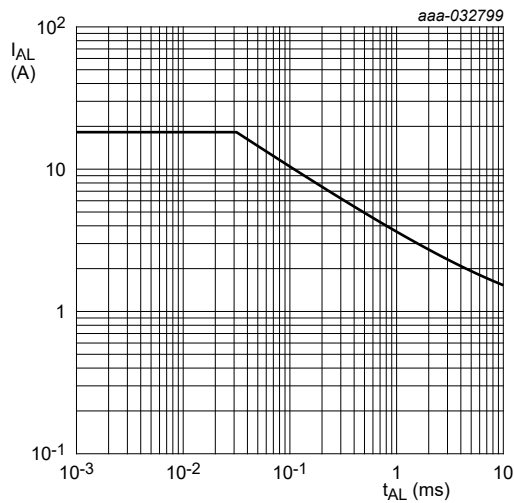


Fig. 6. Percentage $R_{DS(on)}$ at 5V increase as a function of avalanche cycles



$T_{j(\text{init})} = 25\text{ °C}$

Fig. 7. Single pulse avalanche rating; avalanche current as a function of avalanche time

9. Thermal characteristics

Table 6. Thermal characteristics

| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|----------------|---|---|-----|-----|------|------|
| $R_{th(j-mb)}$ | thermal resistance from junction to mounting base | Fig. 8 | - | - | 4.68 | K/W |
| $R_{th(j-a)}$ | thermal resistance from junction to ambient | Minimum footprint; mounted on a printed circuit board | - | 95 | - | K/W |

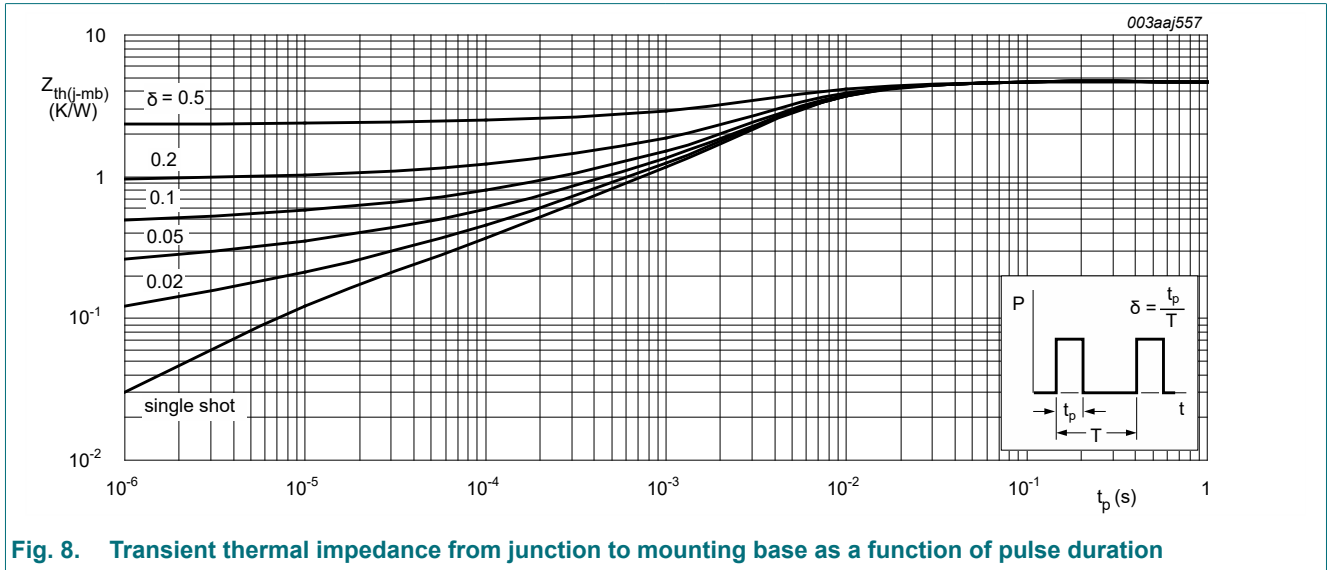


Fig. 8. Transient thermal impedance from junction to mounting base as a function of pulse duration

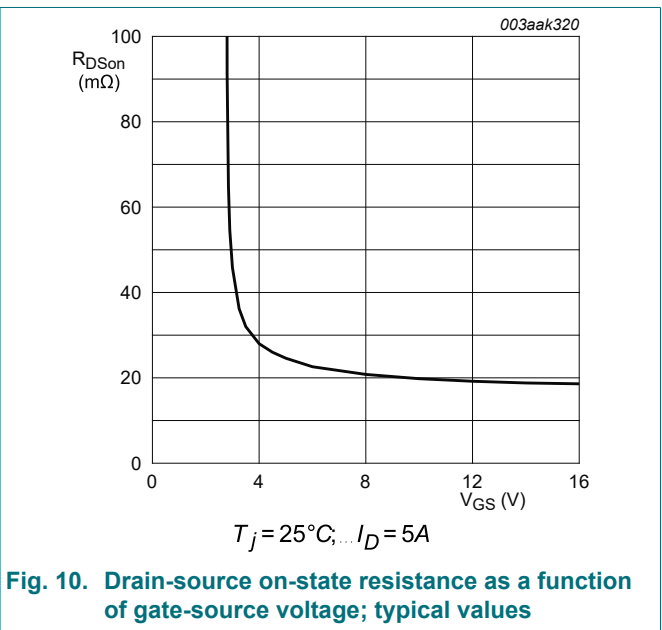
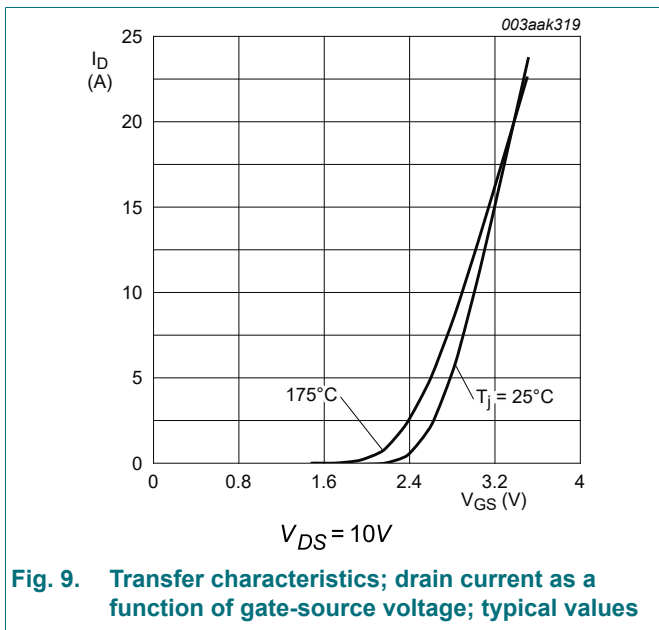
10. Characteristics

Table 7. Characteristics

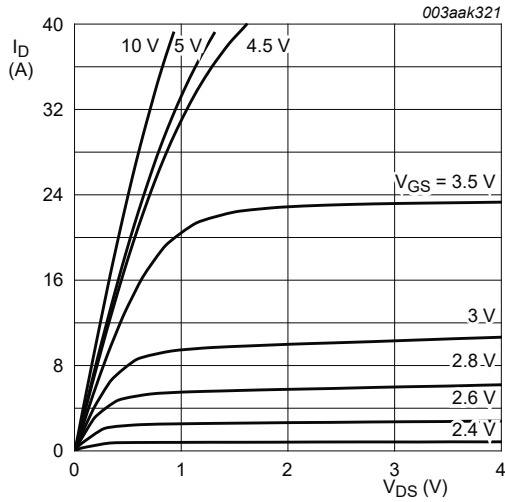
| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|---|----------------------------------|--|-----|------|------|------------|
| Static characteristics FET1 and FET2 | | | | | | |
| $V_{(BR)DSS}$ | drain-source breakdown voltage | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55 \text{ }^\circ C$ | 36 | - | - | V |
| | | $I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25 \text{ }^\circ C$ | 40 | - | - | V |
| $V_{GS(th)}$ | gate-source threshold voltage | $I_D = 1 \text{ mA}; V_{DS}=V_{GS}; T_j = 25 \text{ }^\circ C; \text{ Fig. 12; Fig. 13$ | 1.4 | 1.7 | 2.1 | V |
| | | $I_D = 1 \text{ mA}; V_{DS}=V_{GS}; T_j = 175 \text{ }^\circ C; \text{ Fig. 12; Fig. 13$ | 0.5 | - | - | V |
| | | $I_D = 1 \text{ mA}; V_{DS}=V_{GS}; T_j = -55 \text{ }^\circ C; \text{ Fig. 12; Fig. 13$ | - | - | 2.45 | V |
| I_{DSS} | drain leakage current | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 175 \text{ }^\circ C$ | - | - | 500 | μA |
| | | $V_{DS} = 40 \text{ V}; V_{GS} = 0 \text{ V}; T_j = 25 \text{ }^\circ C$ | - | 0.02 | 1 | μA |
| I_{GSS} | gate leakage current | $V_{GS} = -10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ C$ | - | 2 | 100 | nA |
| | | $V_{GS} = 10 \text{ V}; V_{DS} = 0 \text{ V}; T_j = 25 \text{ }^\circ C$ | - | 2 | 100 | nA |
| R_{DSon} | drain-source on-state resistance | $V_{GS} = 5 \text{ V}; I_D = 5 \text{ A}; T_j = 25 \text{ }^\circ C; \text{ Fig. 14$ | - | 24 | 29 | m Ω |
| | | $V_{GS} = 5 \text{ V}; I_D = 5 \text{ A}; T_j = 175 \text{ }^\circ C; \text{ Fig. 14; Fig. 15$ | - | 48.2 | 58 | m Ω |
| | | $V_{GS} = 10 \text{ V}; I_D = 5 \text{ A}; T_j = 25 \text{ }^\circ C; \text{ Fig. 14$ | - | 19 | 24 | m Ω |

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| Symbol | Parameter | Conditions | Min | Typ | Max | Unit |
|--|------------------------------|---|-----|------|-----|------|
| Dynamic characteristics FET1 and FET2 | | | | | | |
| $Q_{G(tot)}$ | total gate charge | $I_D = 5\text{ A}; V_{DS} = 32\text{ V}; V_{GS} = 5\text{ V};$ $T_j = 25\text{ }^\circ\text{C};$ Fig. 16 ; Fig. 17 | - | 6.3 | - | nC |
| Q_{GS} | gate-source charge | | - | 1.4 | - | nC |
| Q_{GD} | gate-drain charge | | - | 2.4 | - | nC |
| C_{iss} | input capacitance | $V_{DS} = 25\text{ V}; V_{GS} = 0\text{ V}; f = 1\text{ MHz};$ $T_j = 25\text{ }^\circ\text{C};$ Fig. 18 | - | 528 | 701 | pF |
| C_{oss} | output capacitance | | - | 95 | 114 | pF |
| C_{rss} | reverse transfer capacitance | | - | 56 | 76 | pF |
| $t_{d(on)}$ | turn-on delay time | $V_{DS} = 32\text{ V}; R_L = 6.4\text{ }\Omega; V_{GS} = 5\text{ V};$ $R_{G(ext)} = 5\text{ }\Omega; T_j = 25\text{ }^\circ\text{C}$ | - | 6.2 | - | ns |
| t_r | rise time | | - | 9.2 | - | ns |
| $t_{d(off)}$ | turn-off delay time | | - | 10.8 | - | ns |
| t_f | fall time | | - | 8.9 | - | ns |
| Source-drain diode FET1 and FET2 | | | | | | |
| V_{SD} | source-drain voltage | $I_S = 5\text{ A}; V_{GS} = 0\text{ V}; T_j = 25\text{ }^\circ\text{C};$ Fig. 19 | - | 0.83 | 1.2 | V |
| t_{rr} | reverse recovery time | $I_S = 5\text{ A}; di_S/dt = -100\text{ A}/\mu\text{s}; V_{GS} = 0\text{ V};$ $V_{DS} = 20\text{ V}; T_j = 25\text{ }^\circ\text{C}$ | - | 15.9 | - | ns |
| Q_r | recovered charge | | - | 7.6 | - | nC |

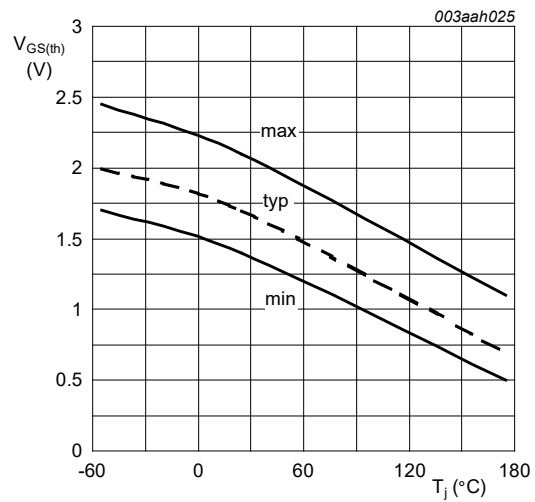


Dual N-channel 40 V, 29 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology



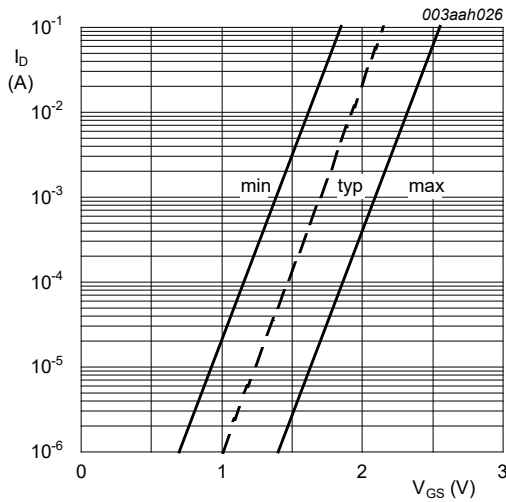
$T_j = 25\text{ }^\circ\text{C}; t_p = 300\text{ }\mu\text{s}$

Fig. 11. Output characteristics; drain current as a function of drain-source voltage; typical values



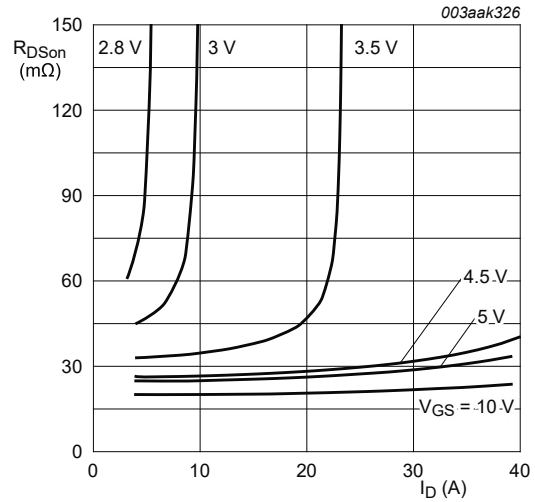
$I_D = 1\text{ mA}; V_{DS} = V_{GS}$

Fig. 12. Gate-source threshold voltage as a function of junction temperature



$T_j = 25\text{ }^\circ\text{C}; \dots V_{DS} = 5V$

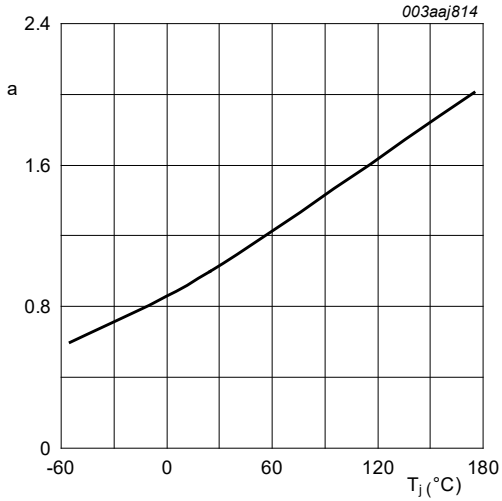
Fig. 13. Sub-threshold drain current as a function of gate-source voltage



$T_j = 25\text{ }^\circ\text{C}; t_p = 300\text{ }\mu\text{s}$

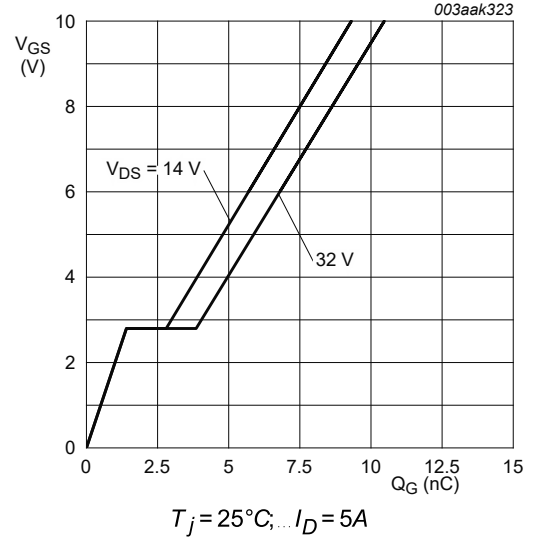
Fig. 14. Drain-source on-state resistance as a function of drain current; typical values

Dual N-channel 40 V, 29 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology



$$a = \frac{R_{DSon}}{R_{DSon.(25^{\circ}C)}}$$

Fig. 15. Normalized drain-source on-state resistance factor as a function of junction temperature



$T_j = 25^{\circ}C, \dots I_D = 5A$

Fig. 16. Gate-source voltage as a function of gate charge; typical values

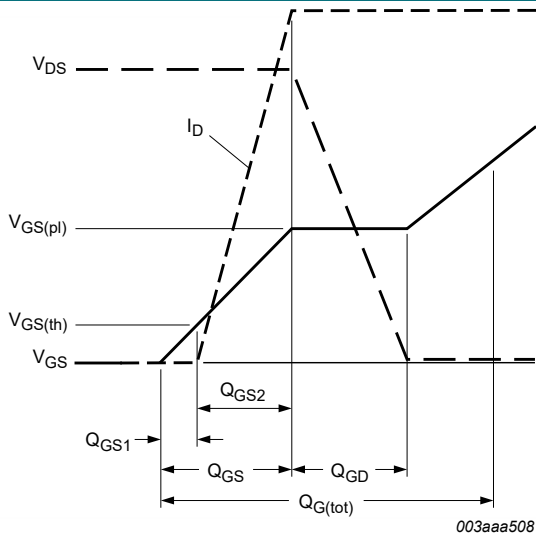
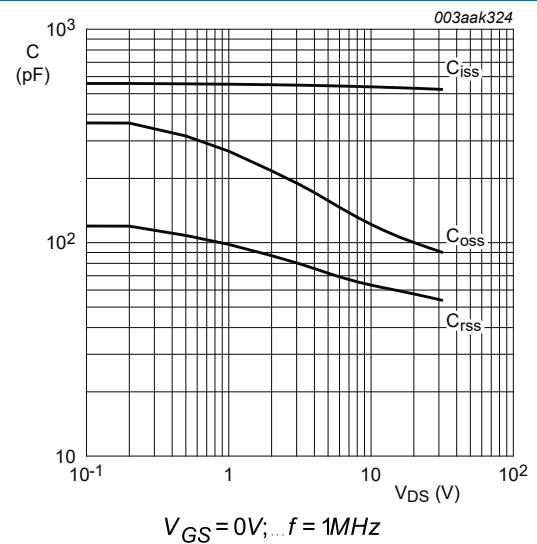


Fig. 17. Gate charge waveform definitions



$V_{GS} = 0V, \dots f = 1MHz$

Fig. 18. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

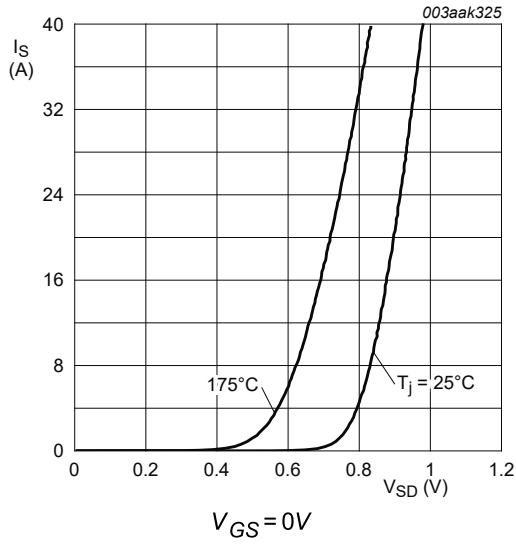


Fig. 19. Source (diode forward) current as a function of source-drain (diode forward) voltage; typical values

11. Package outline

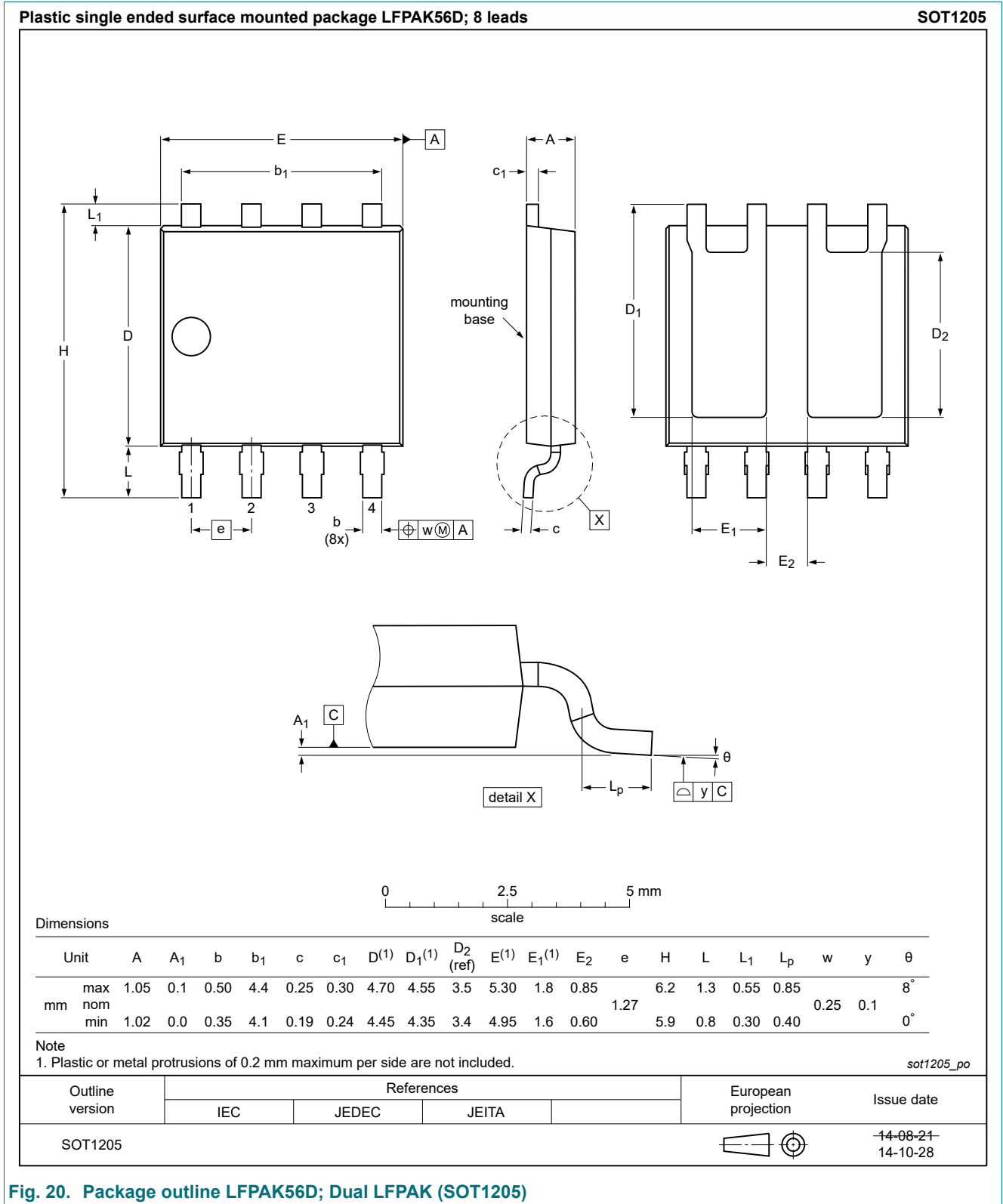


Fig. 20. Package outline LPAK56D; Dual LPAK (SOT1205)

12. Soldering

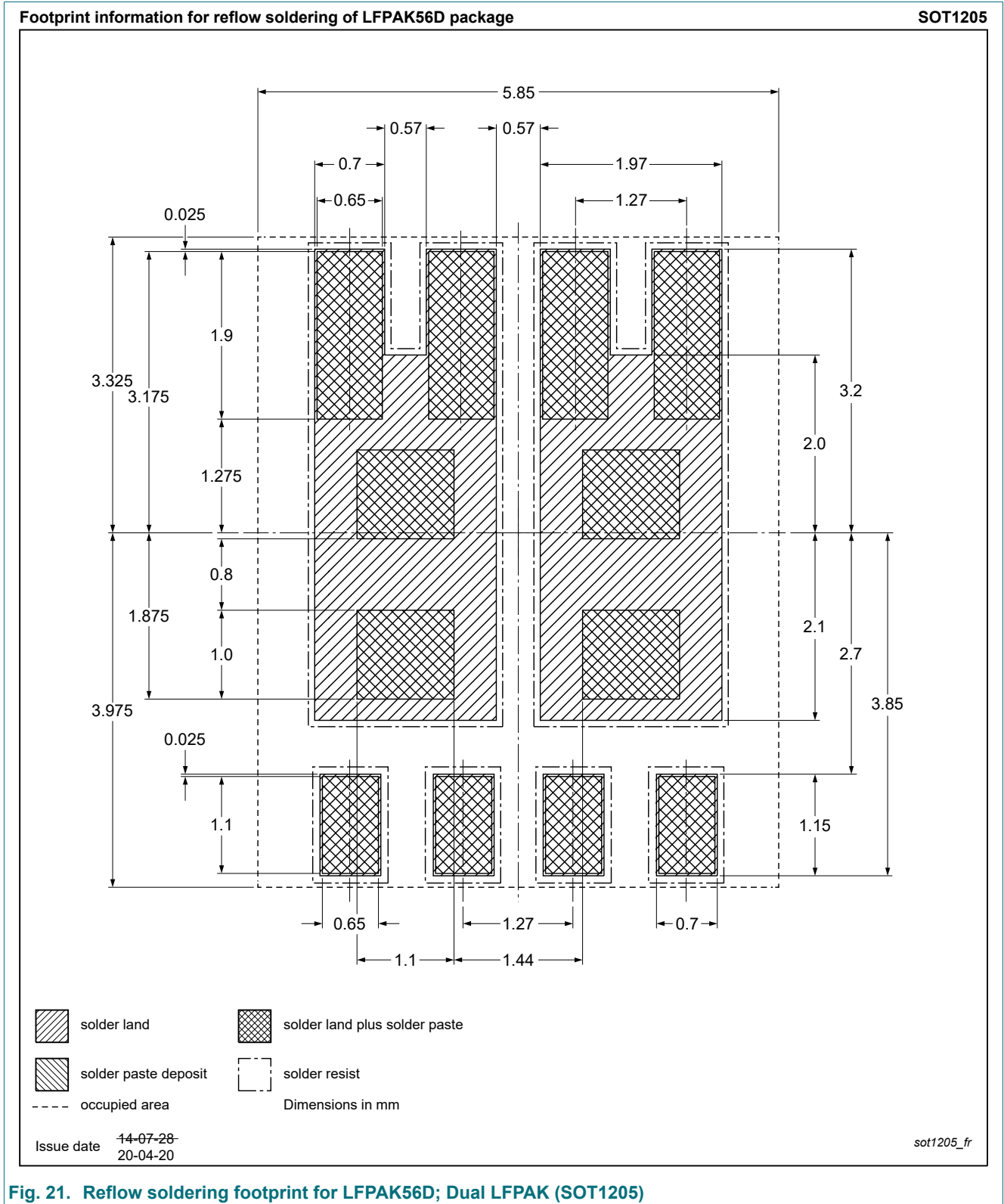


Fig. 21. Reflow soldering footprint for LPAK56D; Dual LPAK (SOT1205)

Dual N-channel 40 V, 29 mOhm logic level MOSFET in LPAK56D using Repetitive Avalanche technology

13. Legal information

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| Document status [1][2] | Product status [3] | Definition |
|--------------------------------|--------------------|---|
| Objective [short] data sheet | Development | This document contains data from the objective specification for product development. |
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